

**N-channel enhancement mode
TrenchMOS™ transistor**
IRFZ44N
GENERAL DESCRIPTION

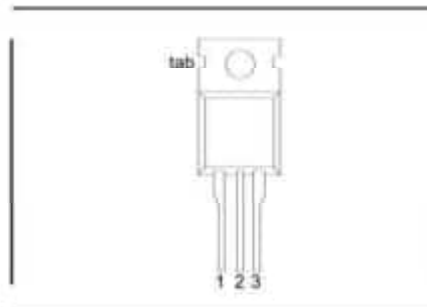
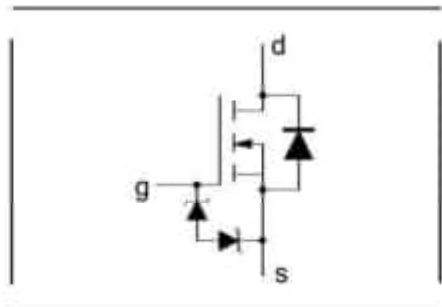
N-channel enhancement mode standard level field-effect power transistor in a plastic envelope using 'trench' technology. The device features very low on-state resistance and has integral zener diodes giving ESD protection up to 2kV. It is intended for use in switched mode power supplies and general purpose switching applications.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V_{DS}	Drain-source voltage	55	V
I_D	Drain current (DC)	49	A
P_{tot}	Total power dissipation	110	W
T_j	Junction temperature	175	°C
$R_{DS(ON)}$	Drain-source on-state resistance $V_{GS} = 10\text{ V}$	22	mΩ

PINNING - TO220AB

PIN	DESCRIPTION
1	gate
2	drain
3	source
tab	drain

PIN CONFIGURATION

SYMBOL

LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	Drain-source voltage	-	-	55	V
V_{DGR}	Drain-gate voltage	$R_{GS} = 20\text{ k}\Omega$	-	55	V
$\pm V_{GS}$	Gate-source voltage	-	-	20	V
I_D	Drain current (DC)	$T_{mb} = 25\text{ }^\circ\text{C}$	-	49	A
I_D	Drain current (DC)	$T_{mb} = 100\text{ }^\circ\text{C}$	-	35	A
I_{DM}	Drain current (pulse peak value)	$T_{mb} = 25\text{ }^\circ\text{C}$	-	160	A
P_{tot}	Total power dissipation	$T_{mb} = 25\text{ }^\circ\text{C}$	-	110	W
T_{stg}, T_j	Storage & operating temperature	-	-55	175	°C

ESD LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_C	Electrostatic discharge capacitor voltage, all pins	Human body model (100 pF, 1.5 kΩ)	-	2	kV

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th(j-mb)}$	Thermal resistance junction to mounting base	-	-	1.4	K/W
$R_{th(j-a)}$	Thermal resistance junction to ambient	in free air	60	-	K/W

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STATIC CHARACTERISTICS
 $T_J = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0\text{ V}; I_D = 0.25\text{ mA};$ $T_J = -55^\circ\text{C}$	55	-	-	V
$V_{GS(TH)}$	Gate threshold voltage	$V_{DS} = V_{GS}; I_D = 1\text{ mA}$ $T_J = 175^\circ\text{C}$ $T_J = -55^\circ\text{C}$	2.0	3.0	4.0	V
I_{DSS}	Zero gate voltage drain current	$V_{DS} = 55\text{ V}; V_{GS} = 0\text{ V};$ $T_J = 175^\circ\text{C}$	-	0.05	10	μA
I_{GSS}	Gate source leakage current	$V_{GS} = \pm 10\text{ V}; V_{DS} = 0\text{ V}$ $T_J = 175^\circ\text{C}$	-	0.04	1	μA
$\pm V_{(BR)GSS}$	Gate source breakdown voltage	$I_G = \pm 1\text{ mA};$ $T_J = 175^\circ\text{C}$	16	-	-	V
$R_{DS(ON)}$	Drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 25\text{ A}$ $T_J = 175^\circ\text{C}$	-	15	22	$\text{m}\Omega$
			-	-	42	$\text{m}\Omega$

DYNAMIC CHARACTERISTICS
 $T_{mb} = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
g_{fs}	Forward transconductance	$V_{DS} = 25\text{ V}; I_D = 25\text{ A}$	6	-	-	S
C_{iss}	Input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 25\text{ V}; f = 1\text{ MHz}$	-	1350	1800	pF
C_{oss}	Output capacitance		-	330	400	pF
C_{rss}	Feedback capacitance		-	155	215	pF
Q_g	Total gate charge	$V_{DD} = 44\text{ V}; I_D = 50\text{ A}; V_{GS} = 10\text{ V}$	-	-	62	nC
Q_{gs}	Gate-source charge		-	-	15	nC
Q_{gd}	Gate-drain (miller) charge		-	-	26	nC
$t_{d\ on}$	Turn-on delay time	$V_{DD} = 30\text{ V}; I_D = 25\text{ A};$ $V_{GS} = 10\text{ V}; R_G = 10\ \Omega$	-	18	26	ns
t_r	Turn-on rise time		-	50	75	ns
$t_{d\ off}$	Turn-off delay time	Resistive load	-	40	50	ns
t_f	Turn-off fall time		-	30	40	ns
L_d	Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nH
L_d	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	4.5	-	nH
L_s	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	7.5	-	nH

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS
 $T_J = 25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{DR}	Continuous reverse drain current		-	-	49	A
I_{DRM}	Pulsed reverse drain current		-	-	160	A
V_{SD}	Diode forward voltage	$I_F = 25\text{ A}; V_{GS} = 0\text{ V}$ $I_F = 40\text{ A}; V_{GS} = 0\text{ V}$	-	0.95	1.2	V
			-	1.0	-	
t_{rr}	Reverse recovery time	$I_F = 40\text{ A}; -dI_F/dt = 100\text{ A}/\mu\text{s};$ $V_{GS} = -10\text{ V}; V_R = 30\text{ V}$	-	47	-	ns
Q_{rr}	Reverse recovery charge		-	0.15	-	μC

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AVALANCHE LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
W_{DSS}	Drain-source non-repetitive unclamped inductive turn-off energy	$I_D = 45 \text{ A}; V_{DD} \leq 25 \text{ V};$ $V_{GS} = 10 \text{ V}; R_{GS} = 50 \Omega; T_{mb} = 25 \text{ }^\circ\text{C}$	-	-	110	mJ

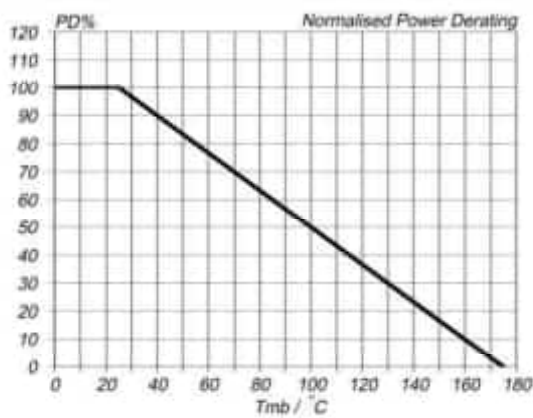


Fig. 1. Normalised power dissipation.
 $PD\% = 100 \cdot P_D / P_{D, 25^\circ\text{C}} = f(T_{mb})$

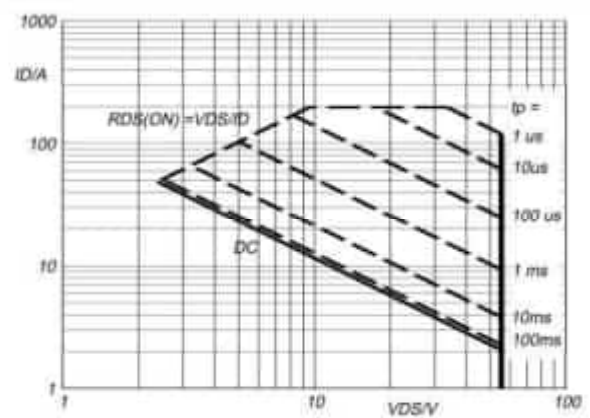


Fig. 3. Safe operating area. $T_{mb} = 25 \text{ }^\circ\text{C}$
 I_D & $I_{DM} = f(V_{DS}); I_{DM}$ single pulse; parameter t_p

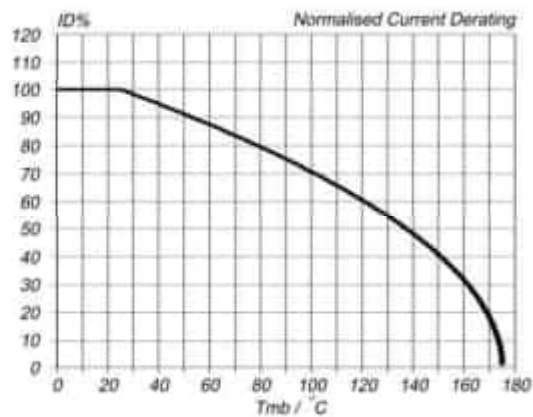


Fig. 2. Normalised continuous drain current.
 $ID\% = 100 \cdot I_D / I_{D, 25^\circ\text{C}} = f(T_{mb});$ conditions: $V_{GS} \geq 10 \text{ V}$

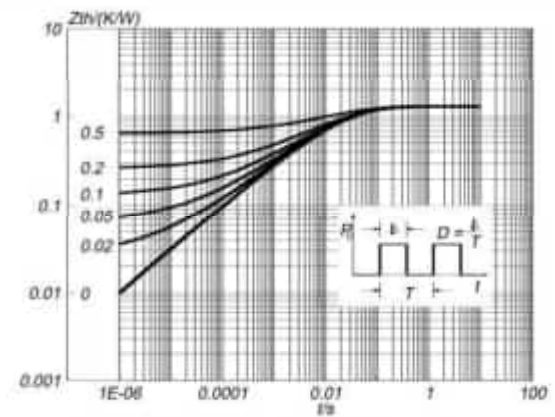


Fig. 4. Transient thermal impedance.
 $Z_{th,j-mb} = f(t);$ parameter $D = t/T$

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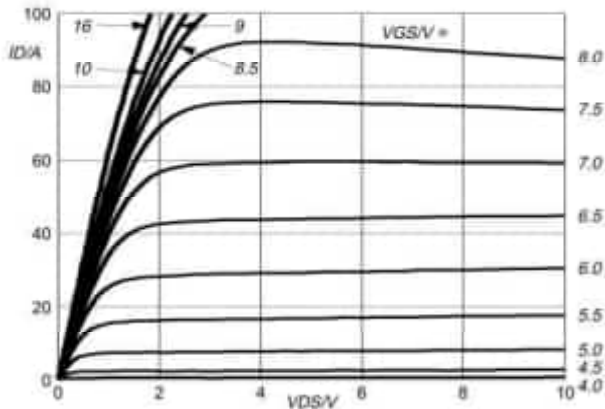


Fig. 5. Typical output characteristics, $T_j = 25\text{ }^\circ\text{C}$.
 $I_D = f(V_{DS})$; parameter V_{GS}

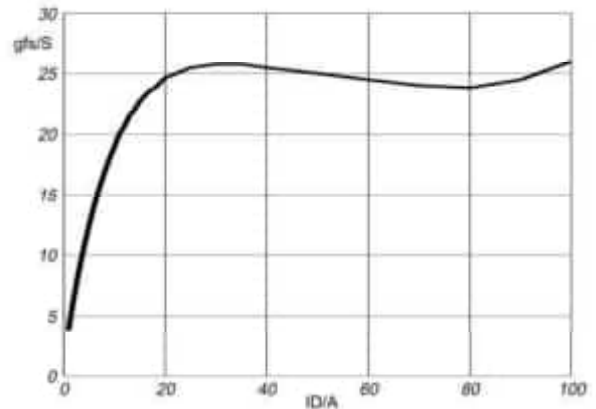


Fig. 8. Typical transconductance, $T_j = 25\text{ }^\circ\text{C}$.
 $g_{fs} = f(I_D)$; conditions: $V_{DS} = 25\text{ V}$

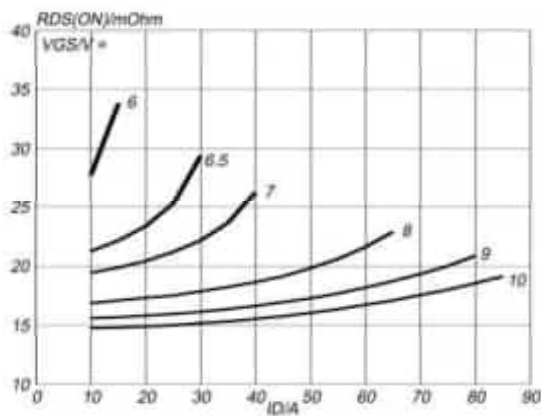


Fig. 6. Typical on-state resistance, $T_j = 25\text{ }^\circ\text{C}$.
 $R_{DS(ON)} = f(I_D)$; parameter V_{GS}

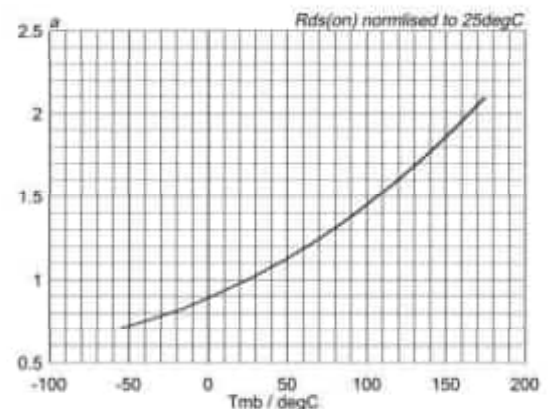


Fig. 9. Normalised drain-source on-state resistance.
 $a = R_{DS(ON)}/R_{DS(ON)25\text{ }^\circ\text{C}} = f(T_j)$; $I_D = 25\text{ A}$; $V_{GS} = 10\text{ V}$

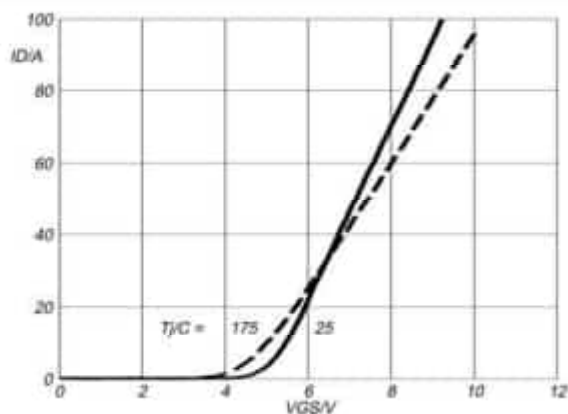


Fig. 7. Typical transfer characteristics.
 $I_D = f(V_{GS})$; conditions: $V_{DS} = 25\text{ V}$; parameter T_j

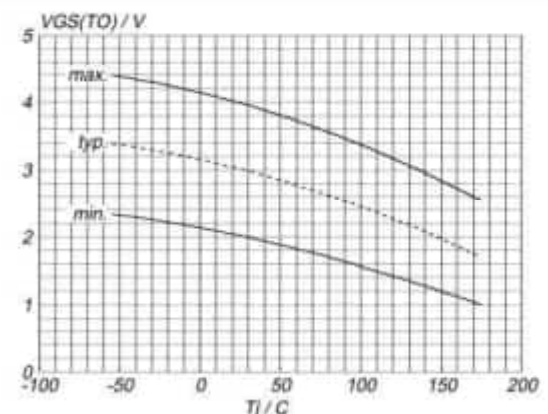


Fig. 10. Gate threshold voltage.
 $V_{GS(T0)} = f(T_j)$; conditions: $I_D = 1\text{ mA}$; $V_{DS} = V_{GS}$

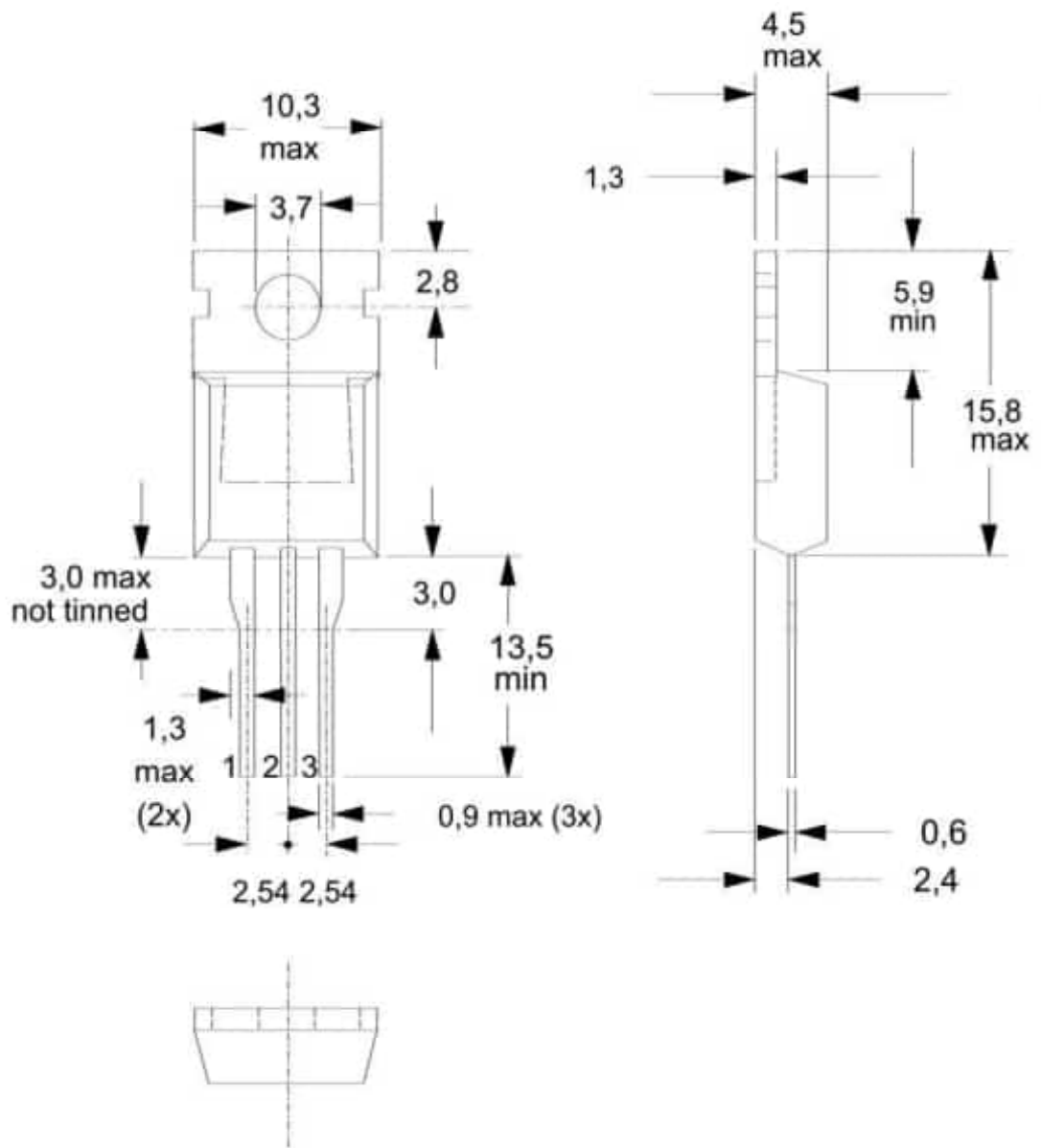
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MECHANICAL DATA

Dimensions in mm

Net Mass: 2 g



Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for SOT78 (TO220) envelopes.
3. Epoxy meets UL94 V0 at 1/8".